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|-----------------------------------|---------------------------------------|--|---|-------------|
| Notice of References Cited | Application/Control No. 10/563,964 | | Applicant(s)/Patent Under Reexamination PFEIFFER ET AL. | |
| | Examiner Manuel L. Barbee | | Art Unit 2857 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|------------------------|----------------|
| * | A | US-4,815,323 A | 03-1989 | Ellinger et al. | 73/290V |
| * | B | US-4,975,615 A | 12-1990 | Katahara, Keith W. | 310/328 |
| * | C | US-RE33,837 E | 03-1992 | Chung et al. | 367/31 |
| * | D | US-5,138,886 A | 08-1992 | Tilley, Sr., Hilton R. | 73/749 |
| * | E | US-6,360,175 B1 | 03-2002 | Cunningham et al. | 702/56 |
| * | F | US-6,449,566 B1 | 09-2002 | Oeschger, John | 702/54 |
| * | G | US-2005/0086012 A1 | 04-2005 | Lapinski et al. | 702/048 |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

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